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SANYEAR

多层片式陶瓷电容器规格书

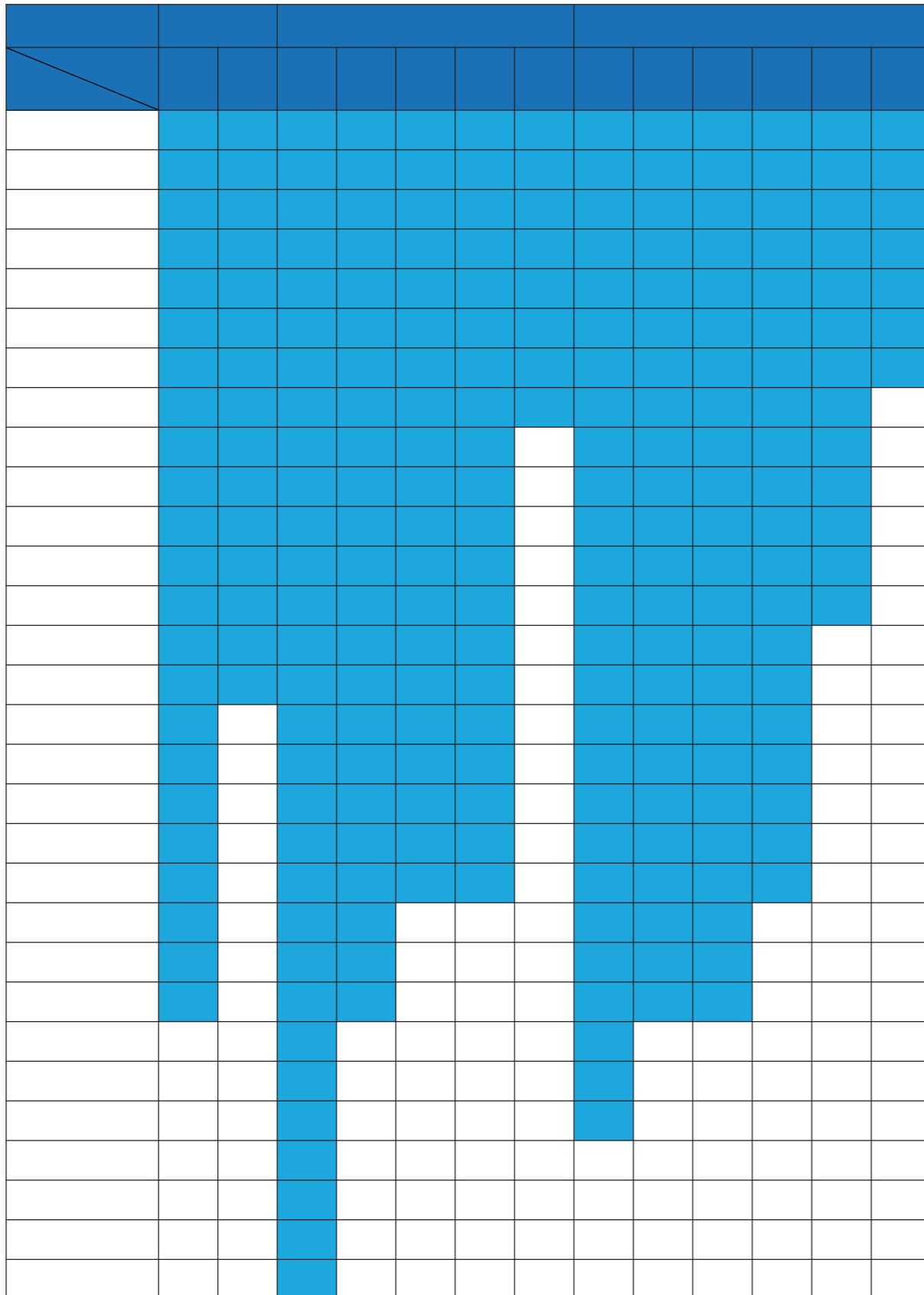
MULTILAYER CHIP CERAMIC CAPACITOR CATALOG

■ 产品容值范围 Product Capacitance Range

背景色代表：可生产型号

材质	COG											
	01005	0201		0402	0603	0805	1206	1210	1808	1812	2220	2225
V _{DC}	6.3	16	50	10	10	10	16	16	16	16	16	16
C _p	10	25		16	16	16	25	25	25	25	25	25
	16			25	25	25	50	50	50	50	50	50
25				50	50	50						
0R47												
0R5												
0R56												
0R68												
0R82												
1R0												
1R2												
1R3												
1R5												
1R8												
2R2												
2R7												
3R3												
3R9												
4R7												
5R6												
6R8												
8R2												
9R0												
100												
120												
150												
180												
220												
270												
330												
390												
470												
560												
680												
750												
820												
101												
121												
151												
181												
221												
271												
331												
391												
471												
511												
561												
681												
821												
102												
122												
152												
182												
222												
272												
332												
392												
472												
562												
682												
822												
103												
123												
153												
183												
223												
273												
333												
473												
563												
104												

■ 技术指标和实验方法 Specifications and Test Method

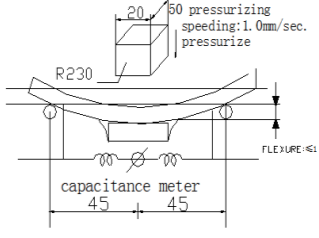


NO	项目 Item	技术指标 Specification	实验方法 Test Method	
1	外观 Appearance	无异常 No abnormalities	通过显微镜视觉检测 (X10) On microscope	
2	尺寸 Dimension	在要求的范围内 Within the specified dimensions	采用精度不低于0.01mm千分尺 Using calipers on micrometer with tolerance no less than 0.01mm	
3	容量(c) Capacitance	在要求的范围内 Within the specified dimensions	Class I : Cp ≤ 1000pF 1MHz ± 10%, 1.0 ± 0.1Vrms Cp > 1000pF 1KHz ± 10%, 1.0 ± 0.1Vrms Class II: Cp < 10 μF 1KHz ± 10%, 1.0 ± 0.1Vrms Cp ≥ 10 μF 120 ± 24Hz, 1.0 ± 0.1Vrms	
4	损耗(Q/DF) Dissipation Factor	C0G		Cp < 30pF, Q ≥ 400+20Cp Cp ≥ 30pF, Q ≥ 1000
		X7R X6S X5R		■ U _R ≥ 100V, DF ≤ 7.5% ■ 25V ≤ U _R ≤ 50V, DF ≤ 3.5% DF ≤ 10% 0201 ≥ 104, 0402 ≥ 333 0603 ≥ 104, 0805 ≥ 684 1206 ≥ 225, 1210 ≥ 475 DF ≤ 12.5% 0402 ≥ 474 ■ U _R ≤ 16V, DF ≤ 5.0% DF ≤ 10%, 0201 ≥ 104, 0402 ≥ 563 0603 ≥ 564, 0805 ≥ 105 1206 ≥ 475, 1210 ≥ 106 ■ U _R ≤ 10V, DF ≤ 7.0% DF ≤ 10% 01005, 0201 ≥ 123 0402 ≥ 224, 0603 ≥ 334 0805 ≥ 225, 1206 ≥ 225 1210 ≥ 226 DF ≤ 15%, 0201 ≥ 104, 0402 ≥ 105 ■ U _R = 6.3V, DF ≤ 10% DF ≤ 15%, 0201 ≥ 104, 0402 ≥ 105 0603 ≥ 106, 0805 ≥ 475 1206 ≥ 476, 1210 ≥ 107 DF ≤ 20%, 0402 ≥ 225 ■ U _R = 4V, DF ≤ 15%
		Y5V		■ U _R ≥ 50V, DF ≤ 12.5% ■ U _R = 25V, DF ≤ 7.0% DF ≤ 9%, 0402 ≥ 683, 0603 ≥ 474 0805 ≥ 105, 1206 ≥ 475 1210 ≥ 106 ■ U _R = 16V, DF ≤ 15% ■ U _R = 10V, DF ≤ 20% ■ U _R ≤ 6.3V, DF ≤ 20%
		高Q		Cp > 30pF Q ≥ 1000 1pF < Cp ≤ 30pF Q ≥ 400+20Cp Cp ≤ 1pF Q ≥ 300
5	绝缘电阻(IR) Insulation Resistance	C0G Ri ≥ 10GΩ 或 500Ω · F, 取最小值 Ri ≥ 10 GΩ 或 500Ω · F, whichever is smaller	施加电压: U _R ≤ 400V U _测 = U _R U _R > 400V U _测 = 400V 充电时间: 60 ± 5秒 To apply voltage: U _R ≤ 400V U _测 = U _R U _R > 400V U _测 = 400V Charge time: 60 ± 5sec	

■ 技术指标和实验方法 Specifications and Test Method

NO	项目 Item	技术指标 Specification	实验方法 Test Method																								
5	绝缘电阻(IR) Insulation Resistance	<p>$R_i \geq 4G\Omega$ 或 $100\Omega \cdot F$ (以下范围为 $50\Omega \cdot F$) 取较小值</p> <p>$R_i \geq 4 G\Omega$ or $100\Omega \cdot F$ ($50\Omega \cdot F$ of below range), whichever is smaller</p> <p>以下范围below range: ■50V: 0402\geq104;0603\geq225; 0805\geq106;1206\geq106 ■25V: 0201\geq104;0402\geq224; 0603\geq106;0805\geq106; 1206\geq226;01005(X6S/ X5R)■16V: 0603\geq106; 01005 (X6S/X5R)■10V: 0201>104; 0603\geq106; 0805\geq476; 01005(X6S/ X5R)■6.3V: 0201\geq104;0603 \geq475;1206\geq106;0100(X6SX5R) ■4V: 0603\geq226;0805\geq 476; 1206\geq107; 01005 (X6SX5R)</p>	<p>施加电压: $U_R \leq 400V$ $U_{测} = U_R$ $U_R > 400V$ $U_{测} = 400V$ 充电时间: 60 ± 5秒</p> <p>To apply voltage: $U_R \leq 400V$ $U_{测} = U_R$ $U_R > 400V$ $U_{测} = 400V$ Charge time: 60 ± 5sec</p>																								
6	耐电压 Dielectric Strength	<p>C0G X7R X6S X5R Y5V</p> <p>无介质击穿和材料裂缝 No dielectric breakdown or mechanical breakdown</p>	<p>施加电压: $U_R < 100V$: 250% $100V \leq U_R < 1000V$: 150% $U_R \geq 1000V$: 120%</p> <p>测试时间: 60 ± 5秒, 最大电流: 不超过50mA</p> <p>To apply voltage: $U_R < 100V$:250%; $100V \leq U_R < 1000V$:150%; $U_R \geq 1000V$:120%</p> <p>Test time: 60 ± 5sec, Max current: should not exceed 50mA</p>																								
*7	电容量温度系数或温度特性 Capatiance Temperature Coefficient Or Temperature Characteristics	<p>C0G 温度系数 $\leq 0 \pm 30ppm/^\circ C$ Temperature coefficient within $0 \pm 30ppm/^\circ C$</p> <p>X7R X6S X5R 容量变化 $\leq \pm 15\%$ Capacitance change within $\pm 15\%$</p> <p>Y5V 容量变化 $\leq +22\% \sim -82\%$ Capacitance change within $+22\% \sim -82\%$</p>	<p>按系列温度顺序测试电容量 Measure capacitance under follow table list</p> <table border="1"> <thead> <tr> <th>步骤Step</th> <th>1</th> <th>2</th> <th>3</th> <th>4</th> <th>5</th> </tr> </thead> <tbody> <tr> <td>C0G/X7R</td> <td>25\pm2$^\circ C$</td> <td>-55\pm3$^\circ C$</td> <td>25\pm2$^\circ C$</td> <td>125\pm3$^\circ C$</td> <td>25\pm2$^\circ C$</td> </tr> <tr> <td>X6S/X5R</td> <td>25\pm2$^\circ C$</td> <td>-55\pm3$^\circ C$</td> <td>25\pm2$^\circ C$</td> <td>85\pm3$^\circ C$</td> <td>25\pm2$^\circ C$</td> </tr> <tr> <td>Y5V</td> <td>25\pm2$^\circ C$</td> <td>-30\pm3$^\circ C$</td> <td>25\pm2$^\circ C$</td> <td>85\pm3$^\circ C$</td> <td>25\pm2$^\circ C$</td> </tr> </tbody> </table> <p>PS:C0G预先干燥: 16-24小时. C0G Preliminary Drying for 16-24hr. ▶$C = [(C_i - C_1) / (C_1 * \Delta T)] * 10^6$ 或 (or) ▶$C = (C_i - C_1) / C_1 * 100\%$ C_i: 1-5温度下的容值 Capacitance value at 1-5 temperature ▶T: 温度变化量 (Temperature variation) ▶$T = T_i - T_1$</p>	步骤Step	1	2	3	4	5	C0G/X7R	25 \pm 2 $^\circ C$	-55 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$	125 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$	X6S/X5R	25 \pm 2 $^\circ C$	-55 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$	85 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$	Y5V	25 \pm 2 $^\circ C$	-30 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$	85 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$
步骤Step	1	2	3	4	5																						
C0G/X7R	25 \pm 2 $^\circ C$	-55 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$	125 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$																						
X6S/X5R	25 \pm 2 $^\circ C$	-55 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$	85 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$																						
Y5V	25 \pm 2 $^\circ C$	-30 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$	85 \pm 3 $^\circ C$	25 \pm 2 $^\circ C$																						
8	附着力 Adhesion	<p>C0G X7R X6S X5R</p> <p>无明显的损伤或端电极脱落 No remarkable damage or removal of the terminations.</p>	<p>施加压力: 5N(0201:2N; 01005:1N) 时间: 10 ± 1秒 Pressurizing force: 5N(0201:2N; 01005:1N) time: 10 ± 1sec</p>																								

■ 技术指标和实验方法 Specifications and Test Method

NO	项目 Item	技术指标 Specification		实验方法 Test Method															
9	可焊性 Solderability	C0G X7R X6S X5R Y5V	端电极挂锡面积小于95% 95%min.coverage of both terminal electrodes	锡炉温度: 245 ± 5℃ 浸入时间: 2 ± 1秒 Solder temperature: 245 ± 5℃ Dipping time: 2 ± 1sec.															
10	弯曲强度 Bending	外观 Appearance	无明显可见损伤 No remarkable visual damage	将电容安在测试夹具上, 按图所示方向以1.0mm/s的速率施加压力, 弯曲1mm. Solder the capacitor on testing substrate and putt on testing stand. The middle part of substrateshall successively be pressurized by pressuringrod at a rated of about 1.0mm/sec. Until the deflection become means of the 1.0mm. 															
		容量变化 Cap change	C0G: ± 5%或 ± 0.5pF, 取较大值 X7R/X6S/X5R: ± 12.5% Y5V: ± 30% C0G: within ± 5% or ± 0.5pF, whichever is larger X7R/X6S/X5R: within ± 12.5% Y5V: within ± 30%																
*11	耐焊锡热 Resistance to Soldering Heat	外观 Appearance	无明显可见损伤 No remarkable visual damage	预热: 120~150℃ 60秒 焊接温度: 270 ± 5%℃ 浸入时间: 10 ± 1秒 Preheating: 120~150℃ 60sec Soldering temperature : 270 ± 5℃ Dipping time: 10 ± 1seconds															
		容量变化 Cap change	C0G: ± 2.5%或 ± 0.5pF, 取较大值 X7R/X6S/X5R: ± 15% Y5V: ± 30% C0G: within ± 2.5% or ± 0.5pF, whichever is larger X7R/X6S/X5R: within ± 15% Y5V: within ± 30%																
		DF/IR	满足产品初始值得要求 Meets initial standard damage																
*12	温度快速循环 Temperature Cycle	外观 Appearance	无明显可见损伤 No remarkable visual damage	按下列步骤进行5次循环: To perform 5cycles of the stated environment <table border="1" data-bbox="2404 1543 2812 1854"> <thead> <tr> <th>步骤 Step</th> <th>温度 Temperature</th> <th>时间 Time</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>下限温度+0/-3℃ Min.operating Temp.+0/-3℃</td> <td>30min</td> </tr> <tr> <td>2</td> <td>25℃</td> <td>2~3min</td> </tr> <tr> <td>3</td> <td>上限温度+3/-0℃ Min.operating Temp.+3/-0℃</td> <td>30min</td> </tr> <tr> <td>4</td> <td>25℃</td> <td>2~3min</td> </tr> </tbody> </table>	步骤 Step	温度 Temperature	时间 Time	1	下限温度+0/-3℃ Min.operating Temp.+0/-3℃	30min	2	25℃	2~3min	3	上限温度+3/-0℃ Min.operating Temp.+3/-0℃	30min	4	25℃	2~3min
		步骤 Step	温度 Temperature		时间 Time														
		1	下限温度+0/-3℃ Min.operating Temp.+0/-3℃		30min														
2	25℃	2~3min																	
3	上限温度+3/-0℃ Min.operating Temp.+3/-0℃	30min																	
4	25℃	2~3min																	
容量变化 Cap change	C0G: ± 2.5%或 ± 0.25pF, 取较大值 X7R/X6S/X5R: ± 15% Y5V: ± 30% C0G: within ± 2.5% or ± 0.25pF, whichever is larger X7R/X6S/X5R: within ± 15% Y5V: within ± 30%																		
DF/IR	满足产品初始值得要求 Meets initial standard damage																		

NO	项目 Item	技术指标 Specification		实验方法 Test Method
		外观 Appearance	容量变化 Cap change	
*13	耐湿负荷 Damp heat with load	外观 Appearance	无明显可见损伤 No remarkable visual damage	测试温度: 40±2℃ 相对湿度: 90~95%RH 测试电压: 额定电压 (最大500V) 测试时间: 500±12hrs Test temperature:40±2℃ Humidity:90~95% RH Voltage:100% of the rated voltage(max:500V) Testing time:500±12hrs
		容量变化 Cap change	C0G: ±7.5%或±0.75pF,取较大值 X7R/X6S/X5R: ±25% Y5V: ±30%或-40%~+30% C0G:within ±7.5% or ±0.75pF, whichever is larger X7R/X6S/X5R: within ±25% Y5V:within ±30%或-40%~+30%	
		DF	初始值的2倍以下 Not more than 2 times of initial value	
		IR	Ri > 500MΩ或25Ω·F(☆为5Ω·F), 取较小值 Ri > 500MΩ或25Ω·F(5Ω·F of ☆), whichever is smaller	
*14	耐久性 Life Test	外观 Appearance	无明显可见损伤 No remarkable visual damage	温度测试: 上限类别温度±3℃ 测试电压: U _R < 100V 150% 100V ≤ U _R < 1000V 120% U _R ≥ 1000V 100% 测试时间: 1000小时 Test temperature:Max.Operating Temp. ±3℃ Voltage: U _R < 100V 150% 100V ≤ U _R < 1000V 120% U _R ≥ 1000V 100% Testing time: 1000hrs
		容量变化 Cap change	C0G: ±3%或±0.5pF,取较大值 X7R/X6S/X5R: ±25% Y5V: ±30%或-40%~+30% C0G:within ±3% or ±0.5pF, whichever is larger X7R/X6S/X5R: within ±25% Y5V:within ±30%或-40%~+30%	
		DF	初始值的2倍以下 Not more than 2 times of initial value	
		IR	Ri > 1GΩ或50Ω·F(☆为10Ω·F), 取较小值 Ri > 1GΩ或50Ω·F(10Ω·F of ☆), whichever is smaller	

注:

*A.3.7.11.12.13.14项需对II类电容器做预处理(将电容器在160℃下热处理1小时),然后在标准大气条件下恢复48±4小时,再测量初始值;

B.3.11.12.13.14项实验后在室温下放置24±2(C0G)或48±4(X7R、X6S、X5R、Y5V)小时以后再测量;

C.3.11.12.13.14项电性能测量的环境条件,温度:25℃±2℃ 相对湿度:25%~80%RH。

☆ ■ 100V:X7R

■ 50V:0402>103; 0603≥105;0805≥105;1206≥475;1210≥475

■ 25V:0201≥104;0402≥224 0603≥225; 0805≥225;1206≥106;1210≥106;01005(X6S/X5R)

■ 16V: 0201≥104;0402≥224;0603≥105; 0805≥225;1206≥106;1210≥476; 01005(X6S/X5R)

■ 10V: 0201≥473;0402≥474;0603≥474; 0805≥225;1206≥475;1210≥476; 01005(X6S/X5R)

■ ≤6.3V Class II; 01005(X6S/X5R)

Note:

A.3.7.11.12.13.14Item need to do the pretreatment of class II type capacitor(Perform a heat treatment at 160℃ for 1 hour),

Then recovery the capacitor at standard pressure conditions for 48±4 hours,Perform the initial measurement

B.3.11.12.13.14Item end of experiment Measurement to be made after being kept at room temperature for 24±2(C0G) or

48±4(X7R、X6S、X5R、Y5V)hrs.

C.3.11.12.13.14Item environmental conditions for electrical performance measurement, Temperature: 25℃±2℃ Humidity:

25%~80%RH

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[NIN-FC2R7JTRF](#) [NMC0201X5R474K4TRPF](#) [NMC0402NPO220J50TRPF](#) [NMC0402X5R105K6.3TRPF](#) [NMC0402X5R224K6.3TRPF](#)
[NMC0402X7R103J25TRPF](#) [NMC0402X7R153K16TRPF](#) [NMC0603NPO1R8C50TRPF](#) [NMC0603NPO201J50TRPF](#)
[NMC0603NPO330G50TRPF](#) [NMC0603X5R475M6.3TRPF](#) [NMC0805NPO270J50TRPF](#) [NMC0805NPO820J50TRPF](#)
[NMC0805X7R224K16TRPLPF](#) [NMC0805X7R224K25TRPF](#) [NMC1206X7R102K50TRPF](#) [NMC1206X7R475K10TRPLPF](#) [NMC-](#)
[L0402NPO7R0C50TRPF](#) [NMC-L0603NPO2R2B50TRPF](#) [NMC-Q0402NPO8R2D200TRPF](#) [C1206C101J1GAC](#) [C1608C0G2A221J](#)
[C1608X7R1E334K](#) [C2012C0G2A472J](#) [2220J2K00562KXT](#) [1812J2K00332KXT](#) [CDR31BX103AKWR](#) [CDR33BX104AKUR](#)
[CDR33BX683AKUS](#) [CGA2B2C0G1H010C](#) [CGA2B2C0G1H040C](#) [CGA2B2C0G1H050C](#) [CGA2B2C0G1H060D](#) [CGA2B2C0G1H070D](#)
[CGA2B2C0G1H120J](#) [CGA2B2C0G1H151J](#) [CGA2B2C0G1H181JT0Y0F](#) [CGA2B2C0G1H1R5C](#) [CGA2B2C0G1H2R2C](#)
[CGA2B2C0G1H390J](#) [CGA2B2C0G1H391J](#) [CGA2B2C0G1H3R3C](#) [CGA2B2C0G1H680J](#) [CGA2B2C0G1H6R8D](#)